Search Notes

Application/Control No	D. Applicant(s)/Par Reexamination	Applicant(s)/Patent under Reexamination WATANABE ET AL.	
10/849,186	WATANABE E		
Examiner	Art Unit		
John S. Chu	1752		

SEARCHED				
Class	Subclass	Date	Examiner	
430	270.1	3/2006	gre	
430	920		1	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
STRUCTURE SEARCH IN HCAPLUS by EIC 1700	3/2006	pse	
EAST SEARCH UPDATED			
INVENTOR SEARCH UPDATED			